

STP270N8F7-VB Datasheet N-Channel 80 V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | | |
|---------------------|--------------------------------------|--|----|--|--|--|
| V _{DS} (V) | $R_{DS(on)}$ (Ω) MAX. | $R_{DS(on)}$ (Ω) MAX. I_D (A) | | | | |
| 80 | 0.0028 at V _{GS} = 10 V | 195 | 94 | | | |
| 80 | 0.0030 at $V_{GS} = 7.5 \text{ V}$ | 185 | 94 | | | |



FEATURES

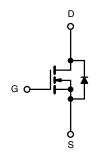
- Trench power MOSFET
- Maximum 175 °C junction temperature
- Very low Q_{gd} reduces power loss from passing through V_{plateau}
- 100 % R_g and UIS tested



FREE

APPLICATIONS

- Power supply
 - Secondary synchronous rectification
- DC/DC converter
- Power tools
- Motor drive switch
- DC/AC inverter
- Battery management



N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted) | | | | | | |
|---|-------------------------|-----------------------------------|------------------|------|--|--|
| PARAMETER | | SYMBOL | LIMIT | UNIT | | |
| Drain-Source Voltage | V_{DS} | 80 | | | | |
| Gate-Source Voltage | V_{GS} | ± 20 | V | | | |
| Continuous Dunis Comment (F. 150 °C) | T _C = 25 °C | | 195 | | | |
| Continuous Drain Current (T _J = 150 °C) | T _C = 70 °C | - I _D | 120 ^d | | | |
| Pulsed Drain Current (t = 100 μs) | | I _{DM} | 600 | A | | |
| Avalanche Current | | I _{AS} | 70 | | | |
| Single Avalanche Energy ^a | L = 0.1 mH | E _{AS} | 245 | mJ | | |
| Marian and David Distriction 2 | T _C = 25 °C | В | 375 b | W | | |
| Maximum Power Dissipation ^a | T _C = 125 °C | - P _D | 125 ^b | | | |
| Operating Junction and Storage Temperature Ra | ınge | T _J , T _{stg} | -55 to +175 | °C | | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|--|-------------------|-------|------|--|--|--|
| PARAMETER | SYMBOL | LIMIT | UNIT | | | |
| Junction-to-Ambient (PCB Mount) ^c | R _{thJA} | 40 | °C/W | | | |
| Junction-to-Case (Drain) | R _{thJC} | 0.4 | C/VV | | | |

Notes

- a. Duty cycle \leq 1 %.
- b. See SOA curve for voltage derating.
- c. When mounted on 1" square PCB (FR4 material).
- d. Package limited.



| PARAMETER | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT | |
|---------------------------------------|----------------------|--|------|--------|-------|------|--|
| Static | | | • | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | 80 | - | - | W | |
| Gate Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_D = 250 \mu A$ | 2 | - | 4 | V | |
| Gate-Body Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | - | - | ± 250 | nA | |
| | | V _{DS} = 80 V, V _{GS} = 0 V | - | - | 1 | | |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 80 V, V _{GS} = 0 V, T _J = 125 °C | - | - | 150 | μA | |
| | | V _{DS} = 80 V, V _{GS} = 0 V, T _J = 175 °C | - | - | 5 | mA | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$ | 120 | - | - | Α | |
| Drain-Source On-State Resistance a | В | V _{GS} = 10 V, I _D = 30 A | - | 0.0028 | - | Ω | |
| Drain-Source On-State Resistance 4 | R _{DS(on)} | V _{GS} = 7.5 V, I _D = 20 A | - | 0.0030 | - | | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = 15 V, I _D = 30 A | - | 82 | - | S | |
| Dynamic ^b | | | | | | | |
| Input Capacitance | C _{iss} | V _{GS} = 0 V, V _{DS} = 40 V, f = 1 MHz | - | 7910 | - | pF | |
| Output Capacitance | C _{oss} | | - | 3250 | - | | |
| Reverse Transfer Capacitance | C _{rss} | | - | 348 | - | | |
| Total Gate Charge ^c | Qg | | - | 94 | 141 | | |
| Gate-Source Charge ^c | Q _{gs} | $V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$ | - | 31 | - | nC | |
| Gate-Drain Charge ^c | Q _{gd} | | - | 10 | - | | |
| Gate Resistance | R_g | f = 1 MHz | 0.28 | 1.4 | 2.8 | Ω | |
| Turn-On Delay Time ^c | t _{d(on)} | | - | 24 | 40 | | |
| Rise Time ^c | t _r | $V_{DD} = 40 \text{ V}, \text{ R}_{L} = 4 \Omega$ | - | 24 | 40 | 20 | |
| Turn-Off Delay Time ^c | t _{d(off)} | $I_D\cong 10~A,~V_{GEN}=10~V,~R_g=1~\Omega$ | - | 34 | 60 | ns | |
| Fall Time ^c | t _f | | - | 14 | 28 | | |
| Drain-Source Body Diode Ratings ar | nd Characteris | stics ^b (T _C = 25 °C) | | | | | |
| Pulsed Current (t = 100 μs) | I _{SM} | | - | - | 250 | Α | |
| Forward Voltage ^a | V_{SD} | I _F = 10 A, V _{GS} = 0 V | - | 0.8 | 1.5 | V | |
| Reverse Recovery Time | t _{rr} | | - | 126 | 190 | ns | |
| Peak Reverse Recovery Charge | I _{RM(REC)} | $I_F = 34 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ | - | 5 | 10 | Α | |
| Reverse Recovery Charge | Q _{rr} | | _ | 0.315 | 0.475 | иC | |

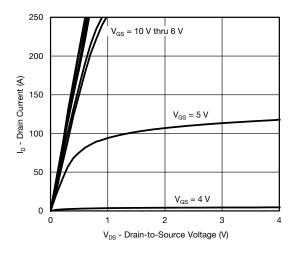
Notes

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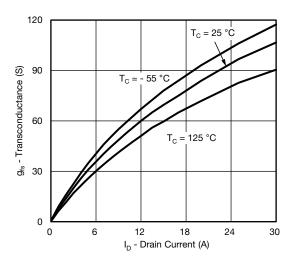
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing. c. Independent of operating temperature.



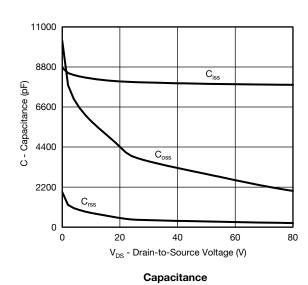
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)

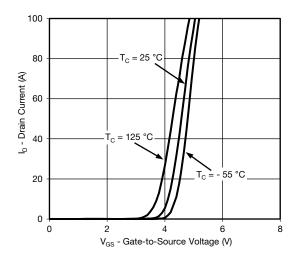


Output Characteristics

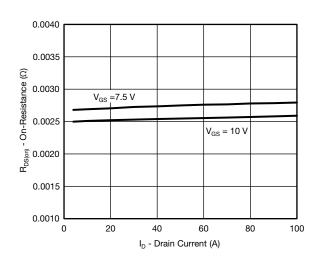


Transconductance

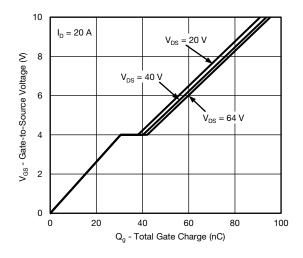




Transfer Characteristics



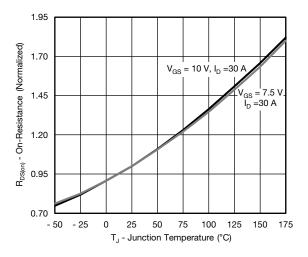
On-Resistance vs. Drain Current



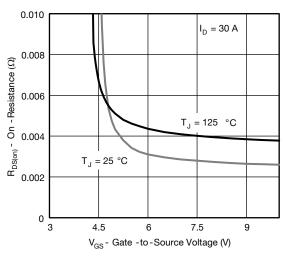
Gate Charge



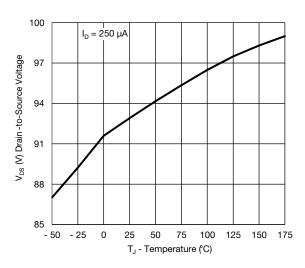
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



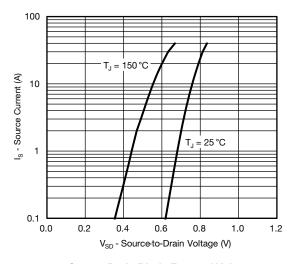
On-Resistance vs. Junction Temperature



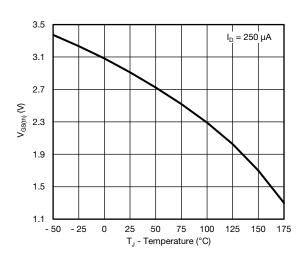
On-Resistance vs. Gate-to-Source Voltage



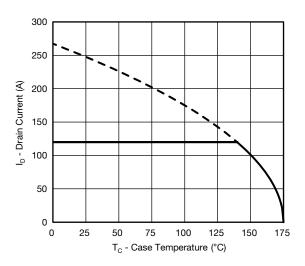
Drain Source Breakdown vs. Junction Temperature



Source Drain Diode Forward Voltage



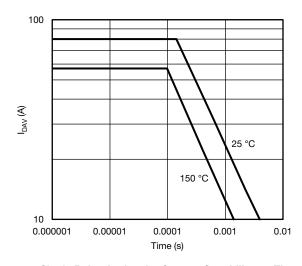
Threshold Voltage



Current De-rating



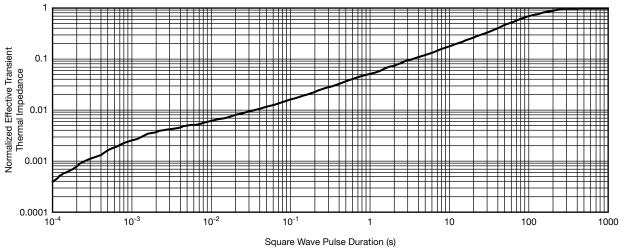
THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)



I_{DM} Limited 10 µs 100 I_D - Drain Current (A) 100 μs 10 Limited by Bsid 1 1 ms 111111 0.1 $T_C = 25^{\circ}C$ 10 ms Single Pulse **BVDSS** Limited 0.01 $\begin{array}{c} 1 & 10 \\ V_{DS}\text{-} Drain-to-Source Voltage (V) \\ ^*V_{GS}> minimum \ V_{GS} \ at \ which \ R_{DS(on)} \ is \ specified \end{array}$ 0.1 100

Single Pulse Avalanche Current Capability vs. Time



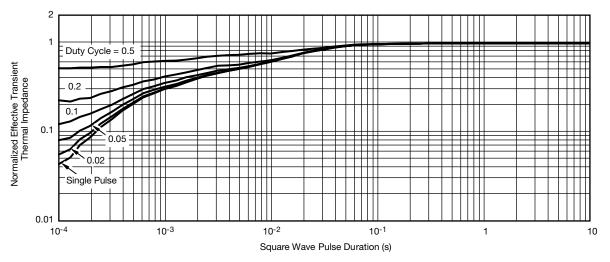


1000

Normalized Thermal Transient Impedance, Junction-to-Ambient



THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



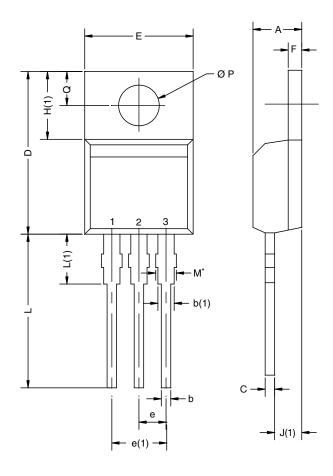
Normalized Thermal Transient Impedance, Junction-to-Case

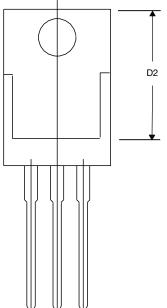
Note

- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction to Ambient (25 °C)
 - Normalized Transient Thermal Impedance Junction to Case (25 °C) are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



TO-220AB





| | MILLIMETERS | | INCHES | | |
|--|-------------|-------|--------|-------|--|
| DIM. | MIN. | MAX. | MIN. | MAX. | |
| А | 4.25 | 4.65 | 0.167 | 0.183 | |
| b | 0.69 | 1.01 | 0.027 | 0.040 | |
| b(1) | 1.20 | 1.73 | 0.047 | 0.068 | |
| С | 0.36 | 0.61 | 0.014 | 0.024 | |
| D | 14.85 | 15.49 | 0.585 | 0.610 | |
| D2 | 12.19 | 12.70 | 0.480 | 0.500 | |
| Е | 10.04 | 10.51 | 0.395 | 0.414 | |
| е | 2.41 | 2.67 | 0.095 | 0.105 | |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 | |
| F | 1.14 | 1.40 | 0.045 | 0.055 | |
| H(1) | 6.09 | 6.48 | 0.240 | 0.255 | |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 | |
| L | 13.35 | 14.02 | 0.526 | 0.552 | |
| L(1) | 3.32 | 3.82 | 0.131 | 0.150 | |
| ØΡ | 3.54 | 3.94 | 0.139 | 0.155 | |
| Q | 2.60 | 3.00 | 0.102 | 0.118 | |
| ECN: T14-0413-Rev. P, 16-Jun-14 DWG: 5471 | | | | | |

Note

 * M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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